

FDJ128N

N-Channel 2.5 Vgs Specified PowerTrench® MOSFET

General Description

This N-Channel -2.5V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

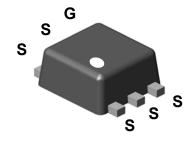
Applications

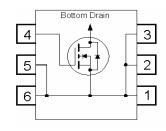
· Battery management

Features

• 5.5 A, 20 V. $R_{DS(ON)} = 35 \text{ m}\Omega \text{ @ V}_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 51 \text{ m}\Omega \text{ @ V}_{GS} = 2.5 \text{ V}$

- · Low gate charge
- High performance trench technology for extremely low $R_{\mbox{\scriptsize DS(ON)}}$
- Compact industry standard SC75-6 surface mount package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		± 12	V
I _D	Drain Current - Continuous	(Note 1a)	5.5	Α
	– Pulsed		16	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.6	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	77	°C/W

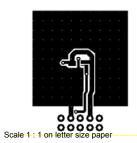
Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.В	FDJ128N	7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA,Referenced to 25°C		12		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μА
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)			•		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	1.0	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 250 μA,Referenced to 25°C		-0.3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ $V_{GS} = 2.5 \text{ V}, I_D = 4.7 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 5.5, T_J = 125^{\circ}\text{C}$		29 41 38	35 51 53	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 4.5 \text{ V}, I_D = 5.5, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$	8			Α
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 5.5 \text{ A}$		19		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 10 V, V _{GS} = 0 V,		543		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		125		pF
C _{rss}	Reverse Transfer Capacitance			65		pF
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		2.0		Ω
Switching	Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 10 V, I _D = 1 A,		7	15	ns
t _r	Turn-On Rise Time	V_{GS} = 4.5 V, R_{GEN} = 6 Ω		5	11	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time			14	24	ns
t _f	Turn-Off Fall Time			3	7	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_{D} = 5.5 \text{ A},$		5	8	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 5 V		1.2		nC
Q_{gd}	Gate-Drain Charge			1.4		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				1.3	Α
V _{SD}	Drain-Source Diode ForwardVoltage	$V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A} \text{(Note 2)}$	1	0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 5.5 A,	1	12		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_{t} = 100 \text{ A/}\mu\text{s}$		3		nC

Notes:

^{1.} R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



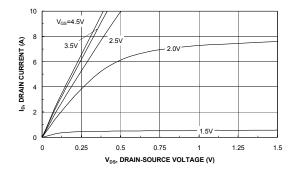
a) 77°C/W when mounted on a 1in² pad of 2 oz



b) 115°C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

Typical Characteristics



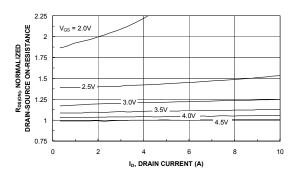


Figure 1. On-Region Characteristics.

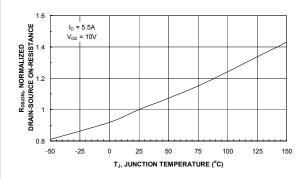


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

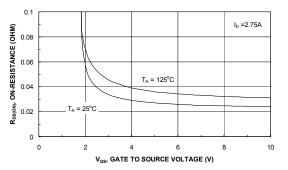


Figure 3. On-Resistance Variation withTemperature.

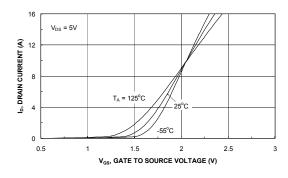


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

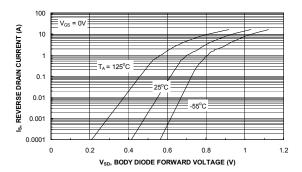
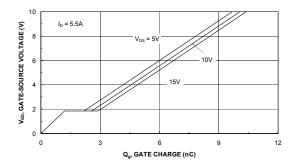


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



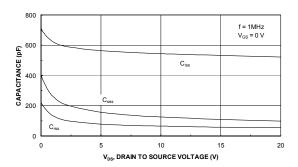


Figure 7. Gate Charge Characteristics.

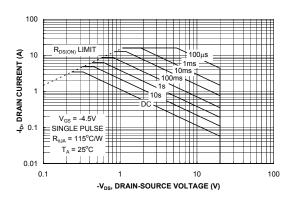


Figure 8. Capacitance Characteristics.

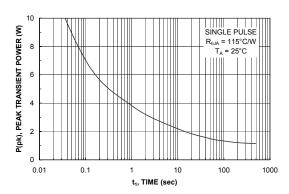


Figure 9. Maximum Safe Operating Area.



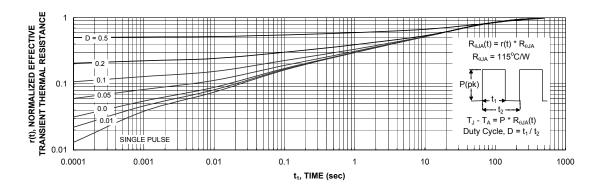


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient themal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout PKG Œ PKG 0.30 MIN-Œ 6 DRAIN TERMINAL 2.35 MIN PKG L PKG Q 0.50 MIN 3 3 1 0.275 0.125 (0.20)0.50 ◆ 0.075M A B 1.00 0.50 LAND PATTERN RECOMMENDATION 1.00 PKG PKG Œ Œ 0.225 0.075 0.80 0.65 1.075 0.925 SEATING PLANE PKG (0.24)DRAIN NOTES: UNLESS OTHERWISE SPECIFIED NO PACKAGE STANDARD REFERENCE AS OF JULY 13, 2000. ALL DIMENSIONS ARE IN MILLIMETERS. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. PKG Q (0.75)(1.20)**BOTTOM VIEW**

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EnSigna™	<i>i-</i> Lo [™]	OCX^{TM}	RapidConnect™	UHC™
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